

03560.002597.1

PATENT APPLICATION



IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of:	)	
	:	Examiner: Courtney D. Thomas
HIDEYUKI CHINJU, et al.	)	
	:	Group Art Unit: 2882
Application No.: 10/689,031	)	
	:	
Filed: October 21, 2003	)	
	:	
For: SYNCHROTRON RADIATION	)	
MEASUREMENT APPARATUS,	:	
X-RAY EXPOSURE	)	
APPARATUS, AND DEVICE	:	
MANUFACTURING METHOD	)	April 14, 2004

Mail Stop Issue Fee  
Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

REQUEST TO CONSIDER PREVIOUSLY CITED ART

Sir:

Applicants have received a Notice of Allowance in the above-identified application dated March 24, 2004 which failed to include an initialed copy of Form PTO-1449 which accompanied the October 20, 2003 Preliminary Amendment and Information Disclosure Statement.

Accordingly, Applicants request the Examiner to indicate that this information has been considered by initialing the appropriate portion of Form PTO-1449, and to return a copy of the initialed Form PTO-1449 to Applicants' undersigned attorney. In this regard, a copy of the Form PTO-1449 which accompanied the October 20, 2003 Preliminary Amendment and Information Disclosure Statement is attached for the Examiner's convenience.

Applicants' undersigned attorney may be reached in our Costa Mesa, California office at (714) 540-8700. All correspondence should continue to be directed to our below-listed address.

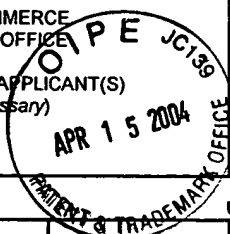
Respectfully submitted,

  
Attorney for Applicants

Registration No. 32622

FITZPATRICK, CELLA, HARPER & SCINTO  
30 Rockefeller Plaza  
New York, New York 10112-2200  
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FORM PTO 1449 (modified)  U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE  LIST OF REFERENCES CITED BY APPLICANT(S) (Use several sheets if necessary)				ATTY DOCKET NO. <b>03560.002597.1</b>		APPLICATION NO. <b>Not Yet Assigned</b>	
				APPLICANT <b>HIDEYUKI CHINJU, et al.</b>			
				FILING DATE <b>Concurrently Herewith</b>		GROUP <b>Not Yet Assigned</b>	
U.S. PATENT DOCUMENTS							
*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
		4,734,685	03/29/1988	Watanabe	340	710	
		5,204,887	04/20/1993	Hayashida, et al.	378	43	
		5,285,488	02/08/1994	Watanabe, et al.	378	34	
		5,444,758	08/22/1995	Miyake, et al.	389	113	
		5,448,612	09/05/1995	Kasumi, et al.	378	84	
		5,835,560	11/10/1998	Amemiya, et al.	378	34	
		5,930,324	07/27/1999	Matsui, et al.	378	34	
		6,081,581	06/27/2000	Hasegawa	378	145	
		6,160,865	12/12/2000	Ogushi	378	34	
		6,385,497	05/07/2002	Ogushi, et al.	700	110	
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT
OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)							
EXAMINER				DATE CONSIDERED			

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy form with next communication to applicant.